



Substitute Form PTO-1449 (Modified)	U.S. Department of Commerce Patent and Trademark Office	Attorney's Docket No. 06618-928001	Application No. 10/772,218
		Applicant Anatoliy Savchenkov et al.	
		Filing Date February 3, 2004	Group Art Unit <del>2872</del> 2874

**Information Disclosure Statement  
by Applicant**  
(Use several sheets if necessary)

(37 CFR §1.98(b))

U.S. Patent Documents							
Examiner Initial	Desig. ID	Document Number	Publication Date	Patentee	Class	Subclass	Filing Date If Appropriate
JDL	AA	5723856	3/3/1998	Yao, et al.	250	227.11	
JDL	AB	5777778	7/7/1998	Yao	359	245	
JDL	AC	5917179	6/29/1999	Yao	250	227.11	
JDL	AD	5929430	7/27/1999	Yao, et al.	250	205	
	AE	6138076	3/18/2003	Yao			
JDL	AF	2002/0018611	2/14/2002	Maleki, et al.	385	15	
JDL	AG	6389197	5/14/2002	Iltchenko, et al.	385	28	
JDL	AH	6417957	7/9/2002	Yao	359	334	
JDL	AI	6473218	10/29/2002	Maleki, et al.	359	245	
JDL	AJ	6476959	11/5/2002	Yao	359	334	
JDL	AK	6487233	11/26/2002	Maleki, et al.	372	108	
JDL	AL	6488861	12/3/2002	Iltchenko, et al.	216	24	
JDL	AM	6490039	12/3/2002	Maleki, et al.	356	436	
JDL	AN	2003/0012504	1/16/2003	Iltchenko	385	39	
JDL	AO	6535328	3/18/2003	Yao	359	334	
JDL	AP	6567436	5/20/2003	Yao, et al.	372	32	
JDL	AQ	6580532	6/17/2003	Yao, et al.	398	39	
JDL	AR	6594061	7/15/2003	Huang, et al.	359	239	
JDL	AS	6762869	7/13/2004	Maleki, et al.	359	239	
	AT						

Foreign Patent Documents or Published Foreign Patent Applications								
Examiner Initial	Desig. ID	Document Number	Publication Date	Country or Patent Office	INT. Class	INT. Subclass	Translation	
							Yes	No
JDL	AU	WO0196936	12/20/2001	WIPO	G02F	1/035		
	AV							
	AW							
	AX							

Examiner Signature <i>John D. Lee</i>	Date Considered 02 NOVEMBER 2005
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	AY						Yes	No

Other Documents (include Author, Title, Date, and Place of Publication)		
Examiner Initial	Desig. ID	Document
JDL	AZ	Dan Sadot, et al.; Tunable Optical Filters for Dense WDM Networks; Dec. 1998; IEEE Communications Magazine, pps. 50-55
JDL	AAA	Jaafar M.H. Elmirghani, et al.; Technologies and Architectures for Scalable Dynamic Dense WDM Networks; Feb. 2000; IEEE Communications Magazine, pps. 58-66
JDL	ABB	Vladimir S. Ilchenko, et al.; Whispering-gallery-mode electro-optic modulator and photonic microwave receiver; Feb. 2003; J. Opt. Soc. Am. B, Vol. 20, No. 2, pps. 333-342
JDL	ACC	L.E. Myers, et al.; Quasi-phase-matched optical parametric oscillators in bulk periodically poled LiNbO <sub>3</sub> ; November 1995; J. Opt. Soc. Am. B/Vol. 12, No. 11; pps. 2102-2116

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JDT	AA	2002/0044739	4/18/2002	Vahala et al.	385	30	
JDT	AB	6580851	6/17/2003	Vahala et al.	385	30	
JDT	AC	2003/0231826	12/18/2003	Boyd et al.	385	27	
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	AN							
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